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Form 1449 (Modified)	Atty Docket No:	U.S.
	MIPFP002	10/051,805
Information Disclosure Statement By Applicant	Applicants: Yoshihiro Nakami et al.	
(Use Several Sheets if Necessary)	Filing Date: January 15, 2002	Group: 2673

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class
<i>SMB</i>	A	6,011,547	1/2000	Shiota et al.		
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Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
<i>SMB</i>	L	10-226139	8/1998	Japan			Yes	No
	M							
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Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
<i>SMB</i>	Q	Abstract of Japanese Patent Publication 10-226139, Pub. Date: 25 August 1998, Patent Abstracts of Japan
	R	
	S	
Examiner	<i>Stephen Binich</i>	Date Considered <i>2/15/06</i>

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered.  
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(Use Several Sheets if Necessary)	January 15, 2002	2673

### U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class
<i>SMB</i>	A	6,273,535	8/2001	Inoue et al.		
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### Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
<i>SMB</i>	L	10-191246	7/1998	Japan			Yes	No
<i>SMB</i>	M	11-331596	11/1999	Japan				X
<i>SMB</i>	N	2000-137806	5/2000	Japan				X
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### Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
<i>SMB</i>	Q	Abstract of Japanese Patent Pub. No. 10-191246, Pub. Date: July 21, 1998, Patent Abstracts of Japan
<i>SMB</i>	R	Abstract of Japanese Patent Pub. No. 11-331596, Pub. Date: November 30, 1999, Patent Abstracts of Japan
<i>SMB</i>	S	Abstract of Japanese Patent Pub. No. 2000-137806, Pub. Date: May 16, 2000, Patent Abstracts of Japan
Examiner <i>Stephen Binich</i>		Date Considered <i>2/15/06</i>

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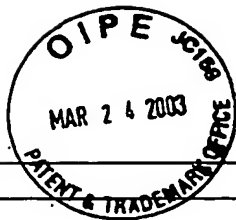
### Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
<i>SMB</i>	L	06-008537	1/1994	Japan				X
<i>SMB</i>	M	09-219817	8/1997	Japan				X
<i>SMB</i>	N	11-041622	2/1999	Japan				X
<i>SMB</i>	O	11-088672	3/1999	Japan				X
<i>SMB</i>	P	11-127415	5/1999	Japan				X

### Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
<i>SMB</i>	Q	Abstract of Japanese Patent Publication No. 06-008537, Pub. Date: January 18, 1994, Patent Abstracts of Japan
<i>SMB</i>	R	Abstract of Japanese Patent Publication No. 09-219817, Pub. Date: August 19, 1997, Patent Abstracts of Japan
<i>SMB</i>	S	Abstract of Japanese Patent Publication No. 11-041622, Pub. Date: February 12, 1999, Patent Abstracts of Japan
<i>SMB</i>	T	Abstract of Japanese Patent Publication No. 11-088672, Pub. Date: March 30, 1999, Patent Abstracts of Japan
<i>SMB</i>	U	Abstract of Japanese Patent Publication No. 11-127415, Pub. Date: May 11, 1999, Patent Abstracts of Japan
Examiner	Date Considered	
<i>Stephen Brinich</i>	<i>2/15/06</i>	

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### U.S. Patent Documents

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### Foreign Patent or Published Foreign Patent Application

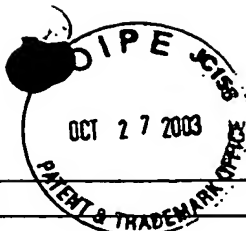
Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
<i>SMB</i>	L-2	2000-013718	1/2000	Japan				X
<i>SMB</i>	M-2	2001-147481	5/2001	Japan				X
	N-2							
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	P-2							

### Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
<i>SMB</i>	Q-2	Abstract of Japanese Patent Publication No. 2000-013718, Pub. Date: January 14, 2000, Patent Abstracts of Japan
<i>SMB</i>	R-2	Abstract of Japanese Patent Publication No. 2001-147481, Pub. Date: May 29, 2001, Patent Abstracts of Japan
	S-2	

Examiner <i>Stephen Brinich</i>	Date Considered <i>2/15/06</i>
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(Use Several Sheets if Necessary)	January 15, 2002	2673

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### Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
<i>SMB</i>	L	11-327605	11/1999	Japan				X
<i>SMB</i>	M	2000-278598	10/2000	Japan			X	
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### Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
<i>SMB</i>	Q	Abstract of Japanese Patent Publication No. 11-327605, Pub. Date: 26 November 1999, Patent Abstracts of Japan
<i>SMB</i>	R	Abstract of Japanese Patent Publication No. 2000-278598, Pub. Date: 6 October 2000, Patent Abstracts of Japan
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Examiner <i>Stephen Blinich</i>	Date Considered <i>2/15/06</i>
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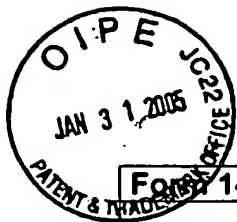
#### Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
<i>SMB</i>	L	11-298848 A	10/1999	Japan	<del>          </del>	<del>          </del>	X	
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#### Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
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Examiner	<i>Stephen Brinich</i>	
	Date Considered	<i>2/15/06</i>

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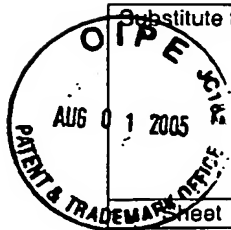
### Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
<i>SmB</i>	L	11-150656	6/1999	Japan			X	
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	N							
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### Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
<i>SmB</i>	Q	Abstract of Japanese Patent Publication No. 11-150656, Pub. Date: 2 June 1999, Patent Abstracts of Japan
	R	
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Examiner	Date Considered	
<i>Stephen Binich</i>	<i>2/15/06</i>	

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Substitute for form 1449/PTO

# **Information Disclosure Statement By Applicant**

(Use as many sheets as necessary)

Sheet

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of

1

Application Number	10/051,805
Filing Date:	January 15, 2002
First Named Inventor:	Yoshihiro NAKAMI
Art Unit:	2673
Examiner Name:	
Attorney Docket Number:	MIPFP002

## **U.S. Patent Documents**

Examiner Initial	Cite No.	Document No.	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear
<i>SMB</i>	A	4,792,847	12/1988	Shimazaki et al.	
<i>SMB</i>	B	5,495,349	2/1996	Ikeda	
<i>SMB</i>	C	6,229,625	5/2001	Nakatsuka	
<i>SMB</i>	D	2003/0193598	10/2003	Takemura	
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## **Foreign Patent Documents**

Examiner Initial	Cite No.	Foreign Patent Document No.	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear	Translation	
						YES	NO
<i>SMB</i>	L	EP 0 757 473	2/1997	Shiraiwa et al.		<input checked="" type="checkbox"/>	
<i>SMB</i>	M	EP 0 838 939	4/1998	Shiota et al.		<input checked="" type="checkbox"/>	
<i>SMB</i>	N	JP 11-027535	1/1999	Nakatsuka			<input checked="" type="checkbox"/>
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	P						
	Q						

## **Non Patent Literature Documents**

Examiner Initial	Cite No.	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
<i>SMB</i>	R	Abstract of Japanese Patent Publication No. 11-027535, Pub. Date: 29 January 1999, Patent Abstracts of Japan
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	V	
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Examiner Signature	<i>Stephen Brinich</i>	Date Considered	2/15/06
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Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.